

### Features

- Low gate charge
- 100% avalanche tested
- Improved dv/dt capability
- RoHS compliant
- Halogen free package
- JEDEC Qualification
- Fast reverse recovery

$$V_{DSS} = 550 \text{ V @ } T_{jmax}$$

$$I_D = 11 \text{ A}$$

$$R_{DS(ON)} = 0.67 \text{ (max) @ } V_{GS} = 10 \text{ V}$$

### Absolute Maximum Ratings

Parameter	Symbol	TMP11N50(G)	TMPF11N50(G)	Unit
Drain-Source Voltage	$V_{DSS}$	500		V
Gate-Source Voltage	$V_{GS}$	±30		V
Continuous Drain Current	$T_C = 25 \text{ }^\circ\text{C}$	11	11 *	A
	$T_C = 100 \text{ }^\circ\text{C}$	6	6 *	A
Pulsed Drain Current (Note 1)	$I_{DM}$	44	44*	A
Single Pulse Avalanche Energy (Note 2)	$E_{AS}$	544		mJ
Repetitive Avalanche Current (Note 1)	$I_{AR}$	11		A
Repetitive Avalanche Energy (Note 1)	$E_{AR}$	15.8		mJ
Power Dissipation	$T_C = 25 \text{ }^\circ\text{C}$	158	51.4	W
	Derate above 25 °C	1.26	0.41	W/°C
Peak Diode Recovery dv/dt (Note 3)	dv/dt	4.5		V/ns
Operating Junction and Storage Temperature Range	$T_J, T_{STG}$	-55~150		°C
Maximum lead temperature for soldering purposes, 1/8" from case for 5 seconds	$T_L$	300		°C

### Thermal Characteristics

Parameter	Symbol			

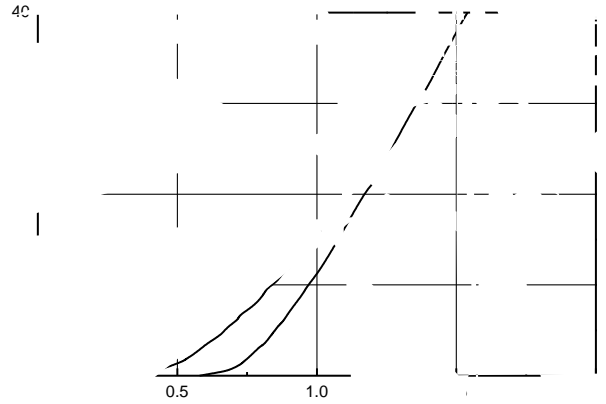
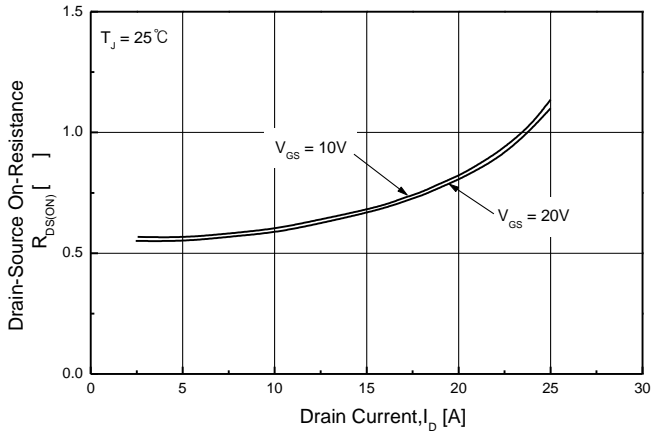
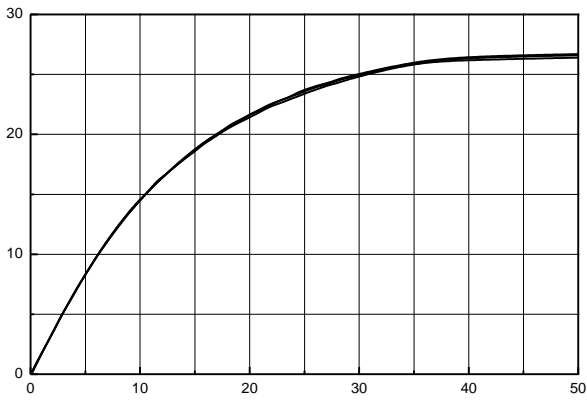
**Electrical Characteristics :  $T_C=25^\circ\text{C}$ , unless otherwise noted**

Parameter	Symbol	Test condition	Min	Typ	Max	Units
<b>OFF</b>						
Drain-Source Breakdown Voltage	$BV_{DSS}$	$V_{GS} = 0\text{ V}, I_D = 250\ \mu\text{A}$	500	--	--	V
Zero Gate Voltage Drain Current	$I_{DSS}$	$V_{DS} = 500\text{ V}, V_{GS} = 0\text{ V}$	--	--	1	$\mu\text{A}$
		$V_{DS} = 400\text{ V}, T_C = 125^\circ\text{C}$	--	--	10	$\mu\text{A}$
Forward Gate-Source Leakage Current	$I_{GSSF}$	$V_{GS} = 30\text{ V}, V_{DS} = 0\text{ V}$	--	--	100	nA
Reverse Gate-Source Leakage Current	$I_{GSSR}$	$V_{GS} = -30\text{ V}, V_{DS} = 0\text{ V}$	--	--	-100	nA

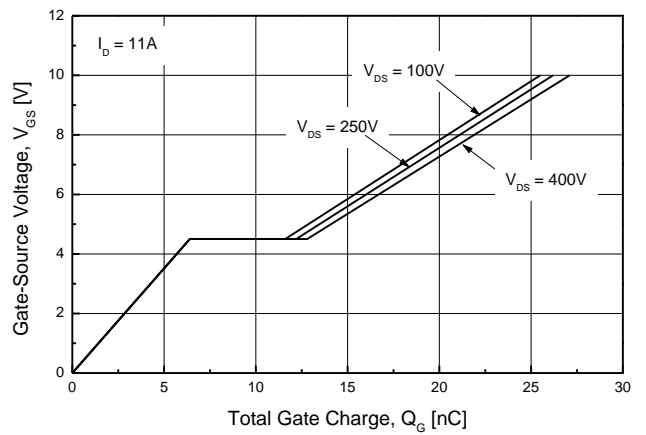
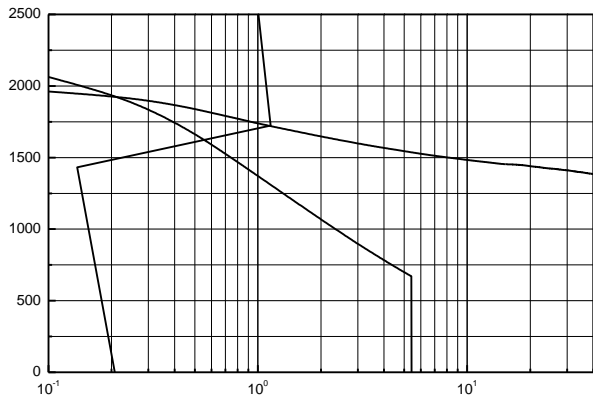
<b>ON</b>						
Gate Threshold Voltage	$V_{GS(th)}$	$V_{DS} = V_{GS}, I_D = 250\ \mu\text{A}$	2	--	4	V
Drain-Source On-Resistance	$R_{DS(on)}$	$V_{GS} = 10\text{ V}, I_D = 5.5\text{ A}$	--	0.54	0.67	
Forward Transconductance <sup>(Note 4)</sup>	$g$					

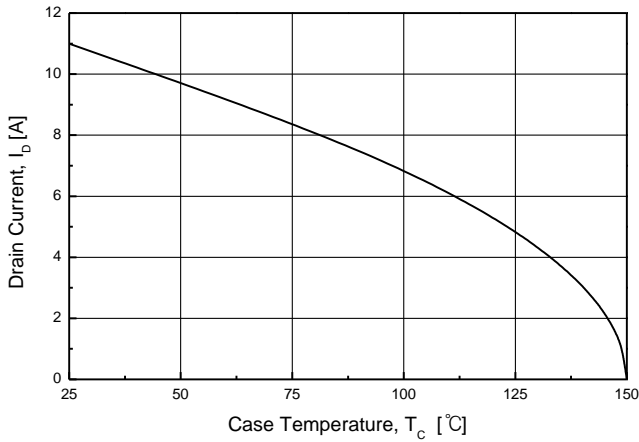
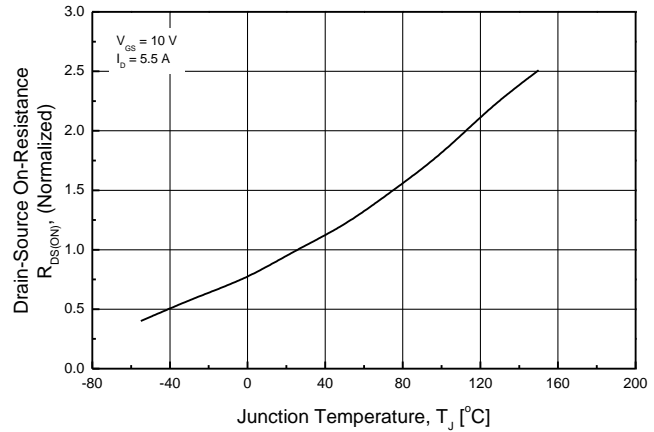
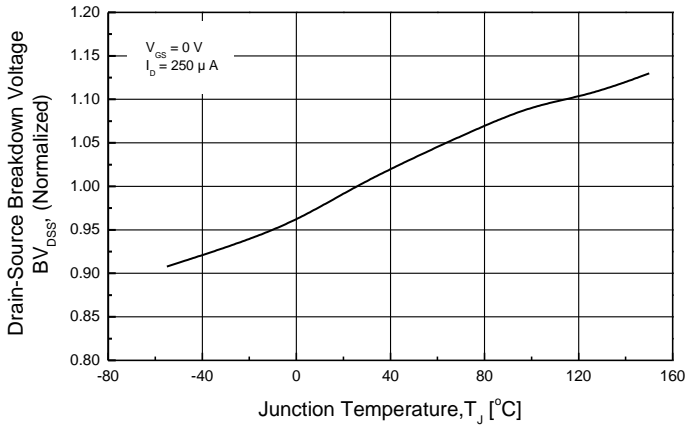



- Note :
1. Repeated rating : Pulse width limited by safe operating area
  2.  $L=8.1\text{mH}, I_{AS} = 11\text{A}, V_{DD} = 50\text{V}, R_G = 25\ \Omega$ , Starting  $T_J = 25^\circ\text{C}$
  3.  $I_{SD} = 11\text{A}, di/dt = 200\text{A}/\mu\text{s}, V_{DD} = BV_{DS}$ , Starting  $T_J = 25^\circ\text{C}$
  4. Pulse Test :Pulse width  $300\mu\text{s}$ , Duty Cycle 2%
  5. Essentially Independent of Operating Temperature Typical Characteristics

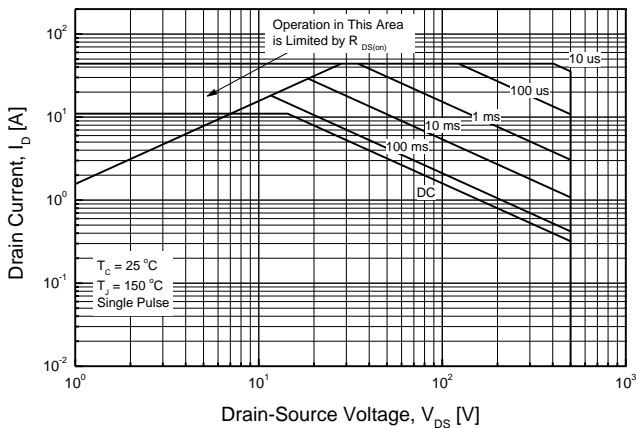


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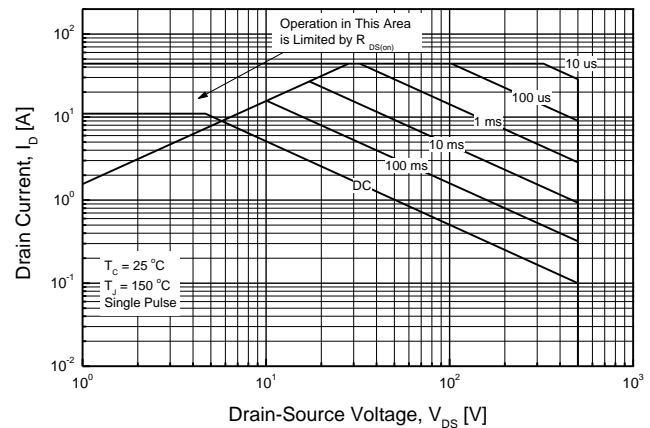




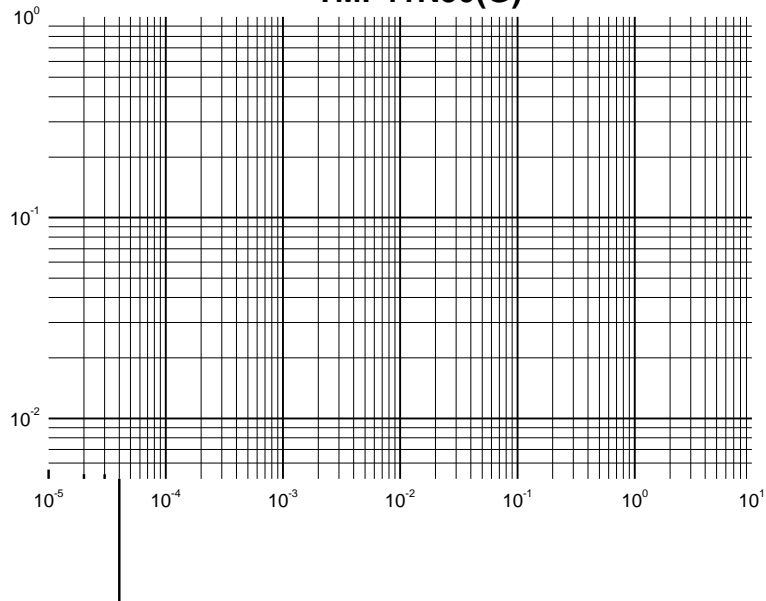
### TMP11N50(G)



### TMPF11N50(G)



TMP11N50(G)



TMPF11N50(G)

